













MAX3221E SLLS686B – OCTOBER 2005 – REVISED SEPTEMBER 2016

# MAX3221E 3-V to 5.5-V Single-Channel RS-232 Line Driver/Receiver With ±15-kV IEC ESD Protection

#### 1 Features

- ESD Protection for RS-232 Pins
  - ±15-kV Human-Body Model (HBM)
  - ±8 kV (IEC 61000-4-2, Contact Discharge)
  - ±15 kV (IEC 61000-4-2, Air-Gap Discharge)
- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates With 3-V to 5.5-V V<sub>CC</sub> Supply
- Operates up to 250 kbit/s
- One Driver and One Receiver
- Low Standby Current: 1 μA Typical
- · Accepts 5-V Logic Input With 3.3-V Supply
- Auto-Power-Down Feature Automatically Disables Drivers for Power Savings
- Alternative High-Speed Device (1 Mbit/s)
  - SN75C3221E and SN65C3221E

# 2 Applications

- Battery-Powered, Hand-Held, and Portable Equipment
- Notebooks and Laptops
- Mobile Phones and Wireless Devices

# 3 Description

The MAX3221E is a single driver, single receiver RS-232 solution operating from a single  $V_{CC}$  supply. The RS-232 pins provide IEC 61000-4-2 ESD protection. The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. These devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/ $\mu$ s driver output slew rate.

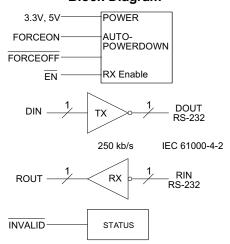
Flexible control options for power management are available. Auto-power down disables driver and charge pump when the receiver is disconnected or the remote driver is power down. The drivers can be manually enabled or disabled. INVALID output goes low when receiver input is unconnected or power off.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
MAX3221ECDB, MAX3221EIDB	SSOP (16)	6.20 mm × 5.30 mm
MAX3221ECPW, MAX3221EIPW	TSSOP (16)	5.00 mm × 4.40 mm

For all available packages, see the orderable addendum at the end of the data sheet.

#### **Block Diagram**



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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

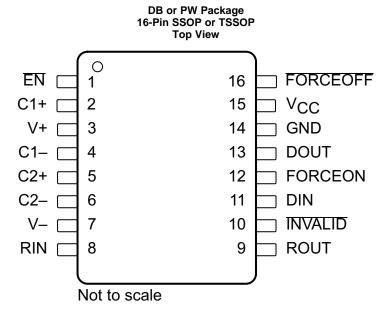
#### Changes from Revision A (May 2006) to Revision B

**Page** 

Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section
 Deleted Ordering Information table; see the POA at the end of the data sheet
 Changed R<sub>θJA</sub> thermal values: 82 to 92 for DB package and 108 to 100.3 for PW Package



# 5 Pin Configuration and Functions



**Pin Functions** 

Р	IN		2500005501
NAME	NO.	1/0	DESCRIPTION
C1+	2		Desitive terminals of the veltage devibler shares number consisters
C2+	5		Positive terminals of the voltage-doubler charge pump capacitors
C1-	4		No getive torrainale of the veltage devibles shares numb conscitus
C2-	6		Negative terminals of the voltage-doubler charge pump capacitors
DIN	11	I	Driver input
DOUT	13	0	RS-232 driver output
EN	1	I	Low input enables receiver ROUT output. High input sets ROUT to high impedance.
FORCEOFF	16	I	Automatic power-down control input
FORCEON	12	I	Automatic power-down control input
GND	14	_	Ground
INVALID	10	0	Invalid output pin. Output low when RIN input is unpowered.
RIN	8	I	RS-232 receiver input
ROUT	9	0	Receiver output
V <sub>CC</sub>	15		3-V to 5.5-V supply voltage
V+	3	0	5.5-V supply generated by the charge pump
V-	7	0	-5.5-V supply generated by the charge pump



# **Specifications**

# 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage <sup>(2)</sup>		-0.3	6	V
V+	Positive output supply voltage <sup>(2)</sup>		-0.3	7	V
V-	Negative output supply voltage (2)		0.3	<b>-</b> 7	٧
V+ - V-	Supply voltage difference <sup>(2)</sup>			13	V
	lanut valta ea	DIN, FORCEOFF, FORCEON, EN	-0.3	6	W
VI	Input voltage	RIN	-25	25	V
	Outrot valtage	DOUT	-13.2	13.2	V
Vo	Output voltage	ROUT, INVALID	-0.3	V <sub>CC</sub> + 0.3	V
$T_J$	Operating virtual junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# 6.2 ESD Ratings

				VALUE	UNIT
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	Pins 8 and 11	±15000		
	numan-body model (nbivi), per ANSI/ESDA/JEDEC 35-001	All other pins	±2000		
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	All pins	±1500	V
	discridingo	IEC 61000-4-2 Contact Discharge, DOUT and RIN	Pins 8 and 11	±8000	
		IEC 61000-4-2 Air-Gap Discharge, DOUT and RIN	Pins 6 and 11	±15000	

 <sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# 6.3 Recommended Operating Conditions

See Figure 11 (1)

	-	MIN	NOM	MAX	UNIT		
	Cumply yeltogo	$V_{CC} = 3.3 \text{ V}$	3	3.3	3.6	V	
	Supply voltage	V <sub>CC</sub> = 5 V	4.5	5	5.5	V	
V	/III Driver and control high-level input voltage   DIN. FORCEOFF. FORCEON. EN 🗁	$V_{CC} = 3.3 \text{ V}$	2			V	
VIH	Driver and control riight-level input voltage	DIN, FORCEOFF, FORCEON, EN	$V_{CC} = 5 V$	2.4			V
$V_{IL}$	Driver and control low-level input voltage	DIN, FORCEOFF, FORCEON, EN				0.8	V
$V_{I}$	Driver and control input voltage	DIN, FORCEOFF, FORCEON		0		5.5	V
$V_{I}$	Receiver input voltage			-25		25	V
т	Operating free-air temperature	MAX3221EC		0		70	°C
T <sub>A</sub>	Operating nee-air temperature	MAX3221EI		-40		85	

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at  $V_{CC}$  = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at  $V_{CC}$  = 5 V  $\pm$  0.5 V.

All voltages are with respect to network GND.



#### 6.4 Thermal Information

		MAX	MAX3221E			
	THERMAL METRIC <sup>(1)</sup>	DB (SSOP)	PW (TSSOP)	UNIT		
		16 PINS	16 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	92	100.3	°C/W		
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	42.8	35.6	°C/W		
$R_{\theta JB}$	Junction-to-board thermal resistance	42.4	45.1	°C/W		
ΨЈТ	Junction-to-top characterization parameter	9.1	2.5	°C/W		
ΨЈВ	Junction-to-board characterization parameter	41.9	44.6	°C/W		

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

#### 6.5 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

	PARAMETI	ER	TEST	CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
II	Input leakage current	FORCEOFF, FORCEON, EN				±0.01	±1	μΑ
		Auto-power down disabled		No load, FORCEOFF and FORCEON at V <sub>CC</sub>		0.3	1	mA
I <sub>CC</sub>	Supply current	Powered off $V_{CC} = 3.3 \text{ V or 5 V},$ $T_A = 25^{\circ}\text{C}$		No load, FORCEOFF at GND		1	10	
		Auto-power down enabled		No load, FORCEOFF at V <sub>CC</sub> , FORCEON at GND, All RIN are open or grounded		1	10	μA

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

#### 6.6 Electrical Characteristics: Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

	PARAMETER	TEST	CONDITIONS		MIN	TYP <sup>(2)</sup>	MAX	UNIT
$V_{OH}$	High-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	DIN = GND		5	5.4		V
$V_{OL}$	Low-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	$DIN = V_{CC}$		<b>-</b> 5	-5.4		V
I <sub>IH</sub>	High-level input current	$V_I = V_{CC}$				±0.01	±1	μΑ
$I_{\rm IL}$	Low-level input current	V <sub>I</sub> = GND				±0.01	±1	μΑ
	Short-circuit	$V_{CC} = 3.6 \text{ V},$	$V_O = 0 V$			±35	±60	mA
los	output current <sup>(3)</sup>	$V_{CC} = 5.5 V,$	$V_O = 0 V$			±35	±60	ША
ro	Output resistance	$V_{CC}$ , V+, and V- = 0 V,	$V_O = \pm 2 V$		300	10M		Ω
	Output lookogo ourrent	FORCEOFF = GND	$V_0 = \pm 12 V$ ,	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$			±25	
loff	I <sub>off</sub> Output leakage current	FURGEOFF = GND	$V_0 = \pm 10 \ V_1$	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$			±25	μA

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.



#### 6.7 Electrical Characteristics: Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
$V_{OH}$	High-level output voltage	$I_{OH} = -1 \text{ mA}$	V <sub>CC</sub> - 0.6	V <sub>CC</sub> - 0.1		V
$V_{OL}$	Low-level output voltage	I <sub>OL</sub> = 1.6 mA			0.4	V
\/	Decitive going input threshold voltage	V <sub>CC</sub> = 3.3 V		1.6	2.4	V
V <sub>IT+</sub>	Positive-going input threshold voltage	V <sub>CC</sub> = 5 V		1.9	2.4	V
\/	Negative gains input threehold veltage	V <sub>CC</sub> = 3.3 V	0.6	1.1		V
V <sub>IT</sub> _	Negative-going input threshold voltage	V <sub>CC</sub> = 5 V	0.8	1.4		V
$V_{\text{hys}}$	Input hysteresis (V <sub>IT+</sub> - V <sub>IT-</sub> )			0.5		V
I <sub>off</sub>	Output leakage current	EN = V <sub>CC</sub>		±0.05	±10	μΑ
r <sub>i</sub>	Input resistance	$V_I = \pm 3 \text{ V to } \pm 25 \text{ V}$	3	5	7	kΩ

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

#### 6.8 Electrical Characteristics: Auto-Power Down

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST C	TEST CONDITIONS		MAX	UNIT
V <sub>T+(valid)</sub>	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND,	FORCEOFF = V <sub>CC</sub>		2.7	V
V <sub>T-(valid)</sub>	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND,	FORCEOFF = V <sub>CC</sub>	-2.7		V
V <sub>T(invalid)</sub>	Receiver input threshold for INVALID low-level output voltage	FORCEON = GND,	FORCEOFF = V <sub>CC</sub>	-0.3	0.3	V
V <sub>OH</sub>	INVALID high-level output voltage	$I_{OH} = -1 \text{ mA}$ , FORCEOFF $= V_{CC}$	DN = GND,	V <sub>CC</sub> - 0.6		V
V <sub>OL</sub>	INVALID low-level output voltage	$\frac{I_{OL} = 1.6 \text{ mA}}{\text{FORCEOFF}} = V_{CC}$	ON = GND,		0.4	V

# 6.9 Switching Characteristics: Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

	PARAMETER TEST CONDITIONS			MIN	TYP <sup>(2)</sup>	MAX	UNIT
	Maximum data rate	$C_L = 1000 \text{ pF},$	$R_L = 3 k\Omega$ ,	150	250		kbit/s
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	$C_L = 150 \text{ pF to } 2500 \text{ pF},$	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$ See Figure 6		100		ns
	Slew rate,	V <sub>CC</sub> = 3.3 V,	C <sub>L</sub> = 150 pF to 1000 pF	6		30	
SR(tr)	transition region (see Figure 5)	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega$	C <sub>L</sub> = 150 pF to 2500 pF	4		30	V/µs

Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Pulse skew is defined as  $|t_{PLH}-t_{PHL}|$  of each channel of the same device.

# 6.10 Switching Characteristics: Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(1)

	PARAMETER	TEST CONDITIONS	TYP <sup>(2)</sup>	UNIT
t <sub>PLH</sub>	Propagation delay time, low- to high-level output	C <sub>L</sub> = 150 pF, See Figure 7	150	ns
t <sub>PHL</sub>	Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF, See Figure 7	150	ns
t <sub>en</sub>	Output enable time	$C_L$ = 150 pF, $R_L$ = 3 k $\Omega$ , See Figure 8	200	ns
t <sub>dis</sub>	Output disable time	$C_L = 150 \text{ pF}, R_L = 3 \text{ k}\Omega, \text{ See Figure 8}$	200	ns
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	See Figure 7	50	ns

<sup>(1)</sup> Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V. (2) All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

Pulse skew is defined as |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device.



# 6.11 Switching Characteristics: Auto-Power Down

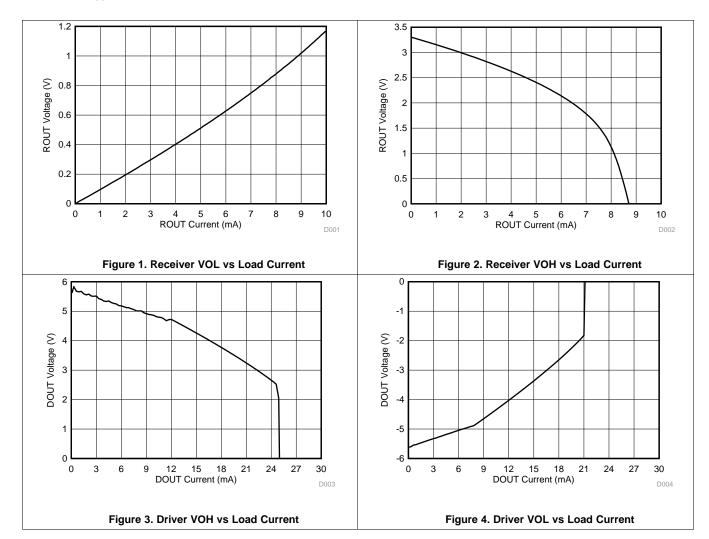
over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TYP <sup>(1)</sup>	UNIT
t <sub>valid</sub>	Propagation delay time, low- to high-level output	1	μs
t <sub>invalid</sub>	Propagation delay time, high- to low-level output	30	μs
t <sub>en</sub>	Supply enable time	100	μs

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

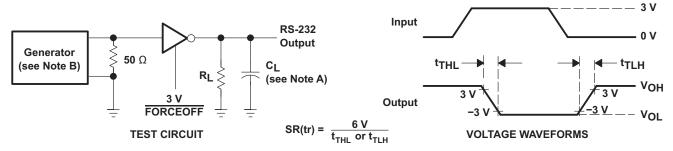
# 6.12 Typical Characteristics

 $T_A = 25^{\circ} C$ ;  $V_{CC} = 3.3 V$ 



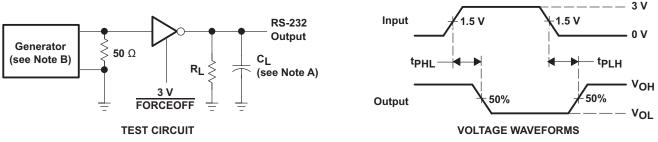
# TEXAS INSTRUMENTS

#### 7 Parameter Measurement Information



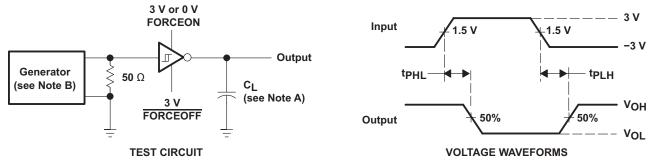
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbps,  $Z_O$  = 50  $\Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 5. Driver Slew Rate



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbps,  $Z_0$  = 50  $\Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 6. Driver Pulse Skew

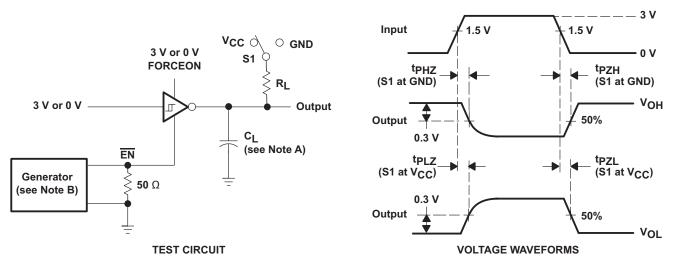


- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_f \le 10 \text{ ns}$ .

Figure 7. Receiver Propagation Delay Times



# **Parameter Measurement Information (continued)**



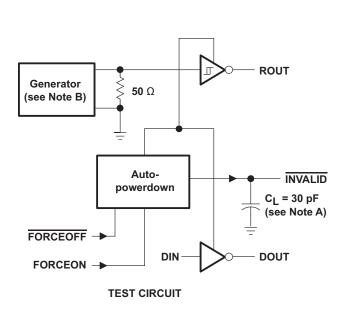
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.
- C. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- D.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

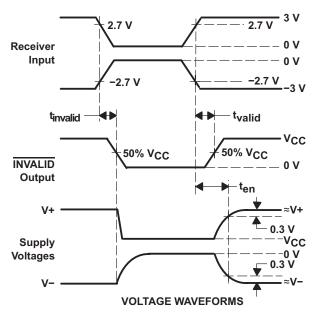
Figure 8. Receiver Enable and Disable Times

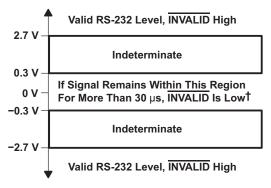
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# **Parameter Measurement Information (continued)**







 $\ensuremath{^{\dagger}}$  Auto-powerdown disables drivers and reduces supply current to 1  $\mu A.$ 

Figure 9. INVALID Propagation Delay Times and Driver Enabling Time



# 8 Detailed Description

#### 8.1 Overview

The MAX3221E is a single driver, single receiver RS-232 solution operating from a single  $V_{CC}$  supply. The RS-232 pins provide IEC 61000-4-2 ESD protection. The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. These devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/ $\mu$ s driver output slew rate.

Flexible control options for power management are available when the serial port is inactive. The auto-power-down feature functions when FORCEON is low and FORCEOFF is high. During this mode of operation, if the device does not sense a valid RS-232 signal on the receiver input, the driver output is disabled. If FORCEOFF is set low and  $\overline{EN}$  is high, both the driver and receiver are shut off, and the supply current is reduced to 1  $\mu$ A. Disconnecting the serial port or turning off the peripheral drivers causes the auto-power-down condition to occur. Auto-power down can be disabled when FORCEON and FORCEOFF are high. With auto-power down enabled, the device is activated automatically when a valid signal is applied to the receiver input. The INVALID output notifies the user if an RS-232 signal is present at the receiver input. INVALID is high (valid data) if the receiver input voltage is greater than 2.7 V or less than -2.7 V, or has been between -0.3 V and 0.3 V for less than 30  $\mu$ s. INVALID is low (invalid data) if the receiver input voltage is between -0.3 V and 0.3 V for more than 30  $\mu$ s. See Figure 5 for receiver input levels.

#### 8.2 Functional Block Diagram

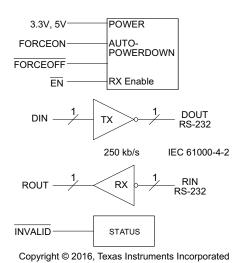


Figure 10. Logic Diagram (Positive Logic)

#### 8.3 Feature Description

#### 8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge <u>pump that requires</u> four external capacitors. Auto-power-down feature for driver is controlled by FORCEON and FORCEOFF inputs. Receiver is controlled by EN input. When MAX3221E is unpowered, it can be safely connected to an active remote RS-232 device.

#### 8.3.2 RS-232 Driver

One driver interfaces standard logic levels to RS-232 levels. DIN input must be valid high or low.



#### **Feature Description (continued)**

#### 8.3.3 RS-232 Receiver

One receiver interfaces RS-232 levels to standard logic levels. An open input results in a high output on ROUT. RIN input includes an internal standard RS-232 load. A logic high input on the EN pin shuts down the receiver output.

#### 8.3.4 RS-232 Status

The  $\overline{\text{INVALID}}$  output goes low when RIN input is unpowered for more than 30 µs. The  $\overline{\text{INVALID}}$  output goes high when receiver has a valid input. The  $\overline{\text{INVALID}}$  output is active when  $V_{cc}$  is powered irregardless of FORCEON and FORCEOFF inputs (see Table 3).

#### 8.4 Device Functional Modes

Table 1, Table 2, and Table 3 show the behavior of the driver, receiver, and INVALID features under all possible relevant combinations of inputs.

**INPUTS OUTPUT DRIVER STATUS VALID RIN DOUT FORCEON FORCEOFF** DIN **RS-232 LEVEL** Χ Ζ Powered off Н Н L Χ Η Normal operation with auto-power down disabled Н Н Η Χ L L Н Yes Н Normal operation with auto-power down enabled Н L Η Yes L L Η No Ζ Powered off by auto-power down feature Н Ζ

Table 1. Function Tables Each Driver (1)

<sup>(1)</sup> H = high level, L = low level, X = irrelevant, Z = high impedance

	INPUTS									
RIN	EN	VALID RIN RS-232 LEVEL	OUTPUT ROUT							
L	L	X	Н							
Н	L	Х	L							
X	Н	X	Z							
Open	L	No	Н							

Table 2. Each Receiver<sup>(1)</sup>

Table 3. INVALID<sup>(1)</sup>

	INPUTS								
RIN	FORCEON	FORCEOFF	EN	INVALID					
L	X	X	X	Н					
Н	X	X	Х	Н					
Open	X	X	X	L					

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off

H = high level, L = low level, X = irrelevant, Z = high impedance (off),
 Open = disconnected input or connected driver off



# 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

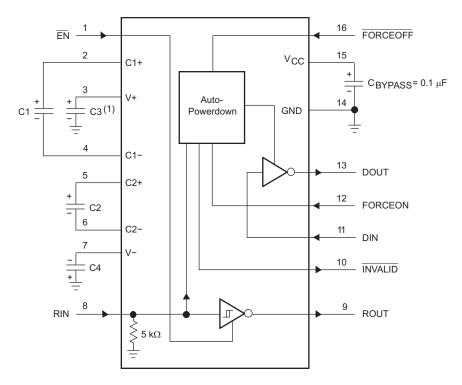
The MAX3221E line driver and receiver is a specialized device for 3-V to 5.5-V RS-232 communication applications. This application is a generic implementation of this device with all required external components. For proper operation, add capacitors as shown in Figure 11.

# 9.2 Typical Application

ROUT and DIN connect to UART or general purpose <u>logic lines</u>. FORCEON and  $\overline{\text{FORCEOFF}}$  may be connected general purpose logic lines or tied to ground or  $V_{CC}$ . INVALID may be connected to a general purpose logic line <u>or left unconnected</u>. RIN and DOUT lines connect to a RS-232 connector or cable. DIN, FORCEON, and FORCEOFF inputs must not be left unconnected.



# **Typical Application (continued)**



(1) C3 can be connected to  $\rm V_{\rm CC}$  or GND.

NOTES: A. Resistor values shown are nominal.

B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

V<sub>CC</sub> vs CAPACITOR VALUES

V <sub>CC</sub>	C1	C2, C3, and C4
3.3 V ± 0.3 V	0.1 μF	0.1 μF
5 V ± 0.5 V 3 V to 5.5 V	0.047 μF 0.1 μF	0.33 μF 0.47 μF

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Figure 11. Typical Operating Circuit and Capacitor Values

# 9.2.1 Design Requirements

- Recommended V<sub>CC</sub> is 3.3 V or 5 V.
  - 3 V to 5.5 V is also possible
- Maximum recommended bit rate is 250 kbps.
- Use capacitors as shown in Figure 11.

# 9.2.2 Detailed Design Procedure

- DIN, FORCEOFF and FORCEON inputs must be connected to valid low or high logic levels.
- Select capacitor values based on VCC level for best performance.

DIN DOUT

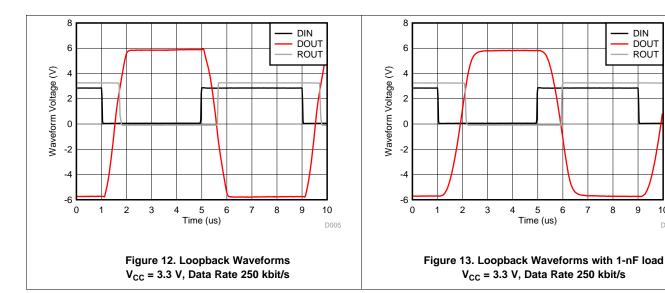
ROUT

D006



# **Typical Application (continued)**

# 9.2.3 Application Curves





# 10 Power Supply Recommendations

TI recommends a  $0.1-\mu F$  capacitor to filter noise on the power supply pin. For additional filter capability, a  $0.01-\mu F$  capacitor may be added in parallel as well. Power supply input voltage is recommended to be any valid level in *Recommended Operating Conditions*.

# 11 Layout

#### 11.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times. Make the impedance from MAX3221E ground pin and circuit board's ground plane as low as possible for best ESD performance. Use wide metal and multiple vias on both sides of ground pin.

# 11.2 Layout Example

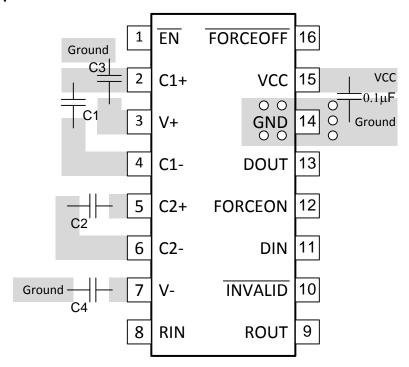


Figure 14. MAX3221E Layout Example



# 12 Device and Documentation Support

#### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.2 Community Resource

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 12.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 12.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





6-Feb-2020

# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
MAX3221ECDB	ACTIVE	SSOP	DB	16	80	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECDBR	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECDBRG4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECPW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECPWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECPWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221ECPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Sample
MAX3221EIDB	ACTIVE	SSOP	DB	16	80	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIDBG4	ACTIVE	SSOP	DB	16	80	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIDBR	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIDBRG4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIPW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIPWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sample
MAX3221EIPWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sampl
MAX3221EIPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sampl
MAX3221EIPWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Sampl

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.



# PACKAGE OPTION ADDENDUM

6-Feb-2020

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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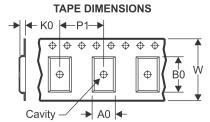
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 17-Apr-2020

# TAPE AND REEL INFORMATION





Α0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

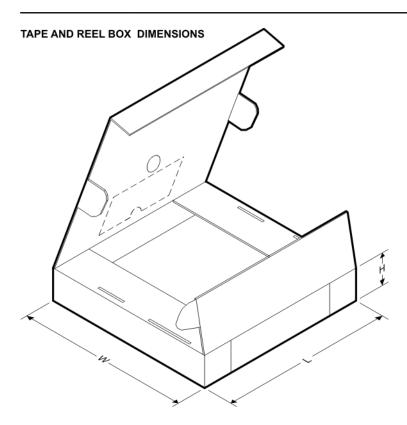


#### \*All dimensions are nominal

All difficusions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3221ECPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

**PACKAGE MATERIALS INFORMATION** 

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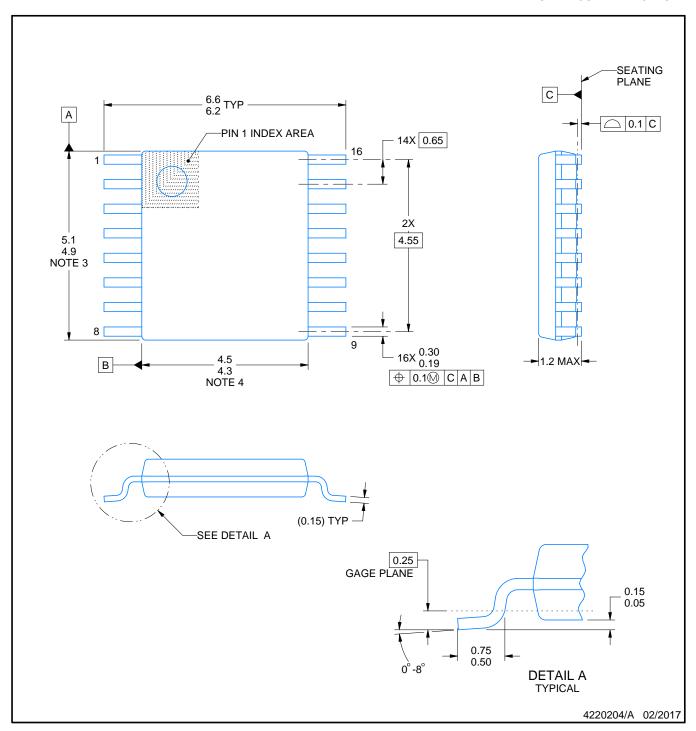


\*All dimensions are nominal

7 till dillitoriolorio di o riorininal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3221ECPWR	TSSOP	PW	16	2000	367.0	367.0	35.0
MAX3221EIPWR	TSSOP	PW	16	2000	367.0	367.0	35.0
MAX3221EIPWR	TSSOP	PW	16	2000	364.0	364.0	27.0
MAX3221EIPWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0



SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



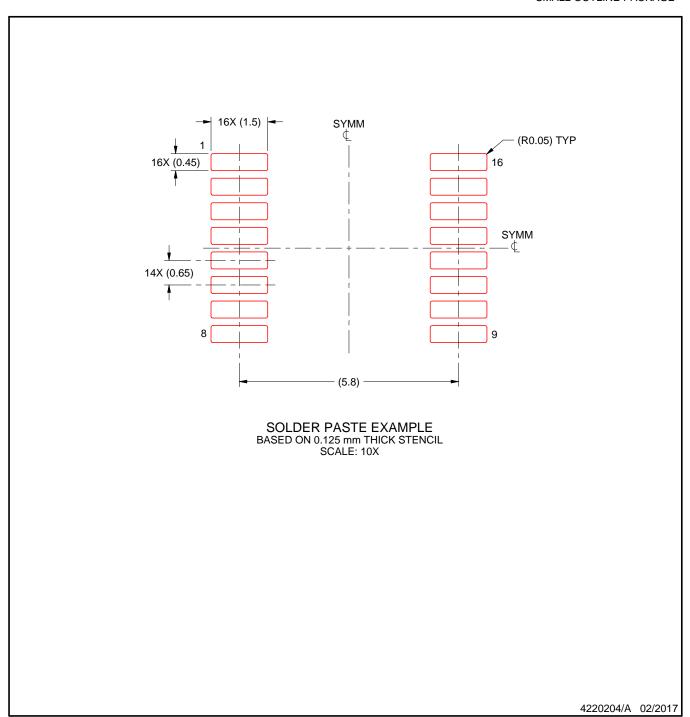
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# DB (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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